

[20103 00201]

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s)

SMIRNOV et al.

Serial No.

To Be Assigned

Filed

Herewith

For

DEVICE FOR FORMING NANOSTRUCTURES ON THE

SURFACE OF A SEMICONDUCTOR WAFER BY MEANS

OF ION BEAMS

Art Unit

To Be Assigned

Examiner

To Be Assigned

Commissioner for Patents Washington, D.C. 20231

PRELIMINARY AMENDMENT AND 37 C.F.R. § 1.125 SUBSTITUTE SPECIFICATION STATEMENT

SIR:

Please amend the above-identified application before examination, as set forth below.

IN THE SPECIFICATION AND ABSTRACT:

In accordance with 37 C.F.R. § 1.121(b)(3), a Substitute Specification (including the Abstract, but without claims) accompanies this response. It is respectfully requested that the Substitute Specification (including Abstract) be entered to replace the Specification of record.

IN THE CLAIMS:

Without prejudice, please cancel original claims 1 -- 3, and please add new claims 4 -- 8 as follows:

- 4. (New) A system for forming nanostructures on a surface of a semiconductor wafer, comprising:
 - a. a vacuum chamber having exhaust and annealing systems;
 - b. an input device inputting a semiconductor wafer into the vacuum chamber;